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Journal of Magnetism and Magnetic Materials

journal homepage: www.elsevier.com/locate/jmmm

# Asymmetric magnetoimpedance effect in ferromagnetic multilayered biphase films



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# ARTICLE INFO

Article history: Received 30 March 2015 Accepted 27 May 2015 Available online 27 May 2015

Keywords: Magnetic systems Magnetization dynamics Magnetoimpedance effect Ferromagnetic films

#### ABSTRACT

We investigate the magnetoimpedance effect in ferromagnetic multilayered biphase films. We verify that the films present asymmetric magnetoimpedance behavior and, by playing with the number of the repetitions of the base structure of the multilayer and the probe current frequency, we explore the possibility of tailoring the linear region around zero magnetic field in order to achieve higher sensitivity values. The highest sensitivity is observed for the thicker film, reaching ~15 m $\Omega$ /Oe at ~0.52 GHz. Thus, the results open the possibilities for application of ferromagnetic multilayered biphase films with asymmetric magnetoimpedance effect in sensors devices.

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# 1. Introduction

The magnetoimpedance effect (MI) corresponds to the change of the real and imaginary components of electrical impedance Z = R + iX of a ferromagnetic conductor caused by the action of an external static magnetic field. In a typical MI experiment, the sample is also submitted to an alternate magnetic field associated to the probe electric current  $I_{ac} = I_o \exp(i2\pi f t)$ , f being the current frequency [1]. The overall effect of these magnetic fields can induce strong modifications of the effective magnetic permeability even when a rather small field is applied, leading to strong variations of the sample's impedance [2].

The MI effect has been widely employed as a versatile tool to investigate ferromagnetic materials. In recent years, the interest for this phenomenon has grown considerably, not only for its contribution to the understanding of fundamental physics associated to magnetization dynamics [3], but also due to the possibility of application of materials exhibiting magnetoimpedance as probe element in sensor devices for low-field detection with fast response under rf magnetic fields [4].

It is well-known that quasi-static magnetic properties play a fundamental role in the dynamic magnetic response and are reflected in the MI behavior [5]. Although soft magnetic materials

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http://dx.doi.org/10.1016/j.jmmm.2015.05.079 0304-8853/© 2015 Elsevier B.V. All rights reserved. are highly sensitive to small field variations, they present a nonlinear MI behavior around zero field. This makes difficult the derivation of an appropriate signal for sensor applications [5,6].

From the practical point of view, MI sensitivity and linearity are the main parameters to be controlled [7]. In this sense, to improve the linear features of the MI response, studies have been carried out considering different magnetic systems, including wires [6,8], amorphous ribbons [7,9], and exchange biased multilayers [10,5]. All of them exhibit asymmetric magnetoimpedance (AMI), characterized by a linear response around zero magnetic field, opening possibilities for the use of this kind of materials for the development of auto-biased linear magnetic field sensors.

Recently, it has been shown that AMI can be obtained in ferromagnetic NiFe/Cu/Co films [11]. For these samples, the linear region of the AMI curves can be tuned by varying the thickness of the spacer and probe current frequency. The films present a biphase magnetic behavior, with hard and soft ferromagnetic phases intermediated by a non-magnetic layer acting together, a fact associated to the kind of the magnetic interaction between the ferromagnetic layers.

In this work, we investigate the magnetoimpedance effect in ferromagnetic multilayered biphase films and play with the number of the repetitions of the base structure of the multilayer and the probe current frequency. We verify that the ferromagnetic multilayered biphase films present asymmetric magnetoimpedance behavior, and explore the possibility of tailoring the linear region around zero magnetic field in order to achieve higher sensitivity values. The results open the possibilities for application of ferromagnetic multilayered biphase films with AMI in autobased sensors devices.

## 2. Experiment

For this study, we produce ferromagnetic multilayered  $[Ni_{81}Fe_{19}(25 \text{ nm})/Cu(7 \text{ nm})/Co(50 \text{ nm})/Ta(10 \text{ nm})] \times n$  films, with n=1, 3 and 5. Fig. 1 shows a representative structure of the films. The samples are deposited by magnetron sputtering onto glass substrates, with dimensions of  $8 \times 4 \text{ mm}^2$ . A buffer Ta layer is deposited before the NiFe layer to reduce the roughness of the substrate, as well as a cap Ta layer is inserted after the Co layer in order to avoid oxidation of the sample. The deposition process is carried out using the following parameters: base vacuum of  $10^{-8}$  Torr, deposition pressure of 2.0 mTorr with a 99.99% pure Ar at 32 sccm constant flow, dc source with power of 150 W for the deposition of the NiFe and Co layers, while 100 W set in the rf power supply for the Cu, and 200 W dcp for the Ta layers.

While low angle x-ray reflectometry results calibrate the sample thicknesses, high angle diffraction measurements verify the structural character of all films. In particular, the diffraction patterns, not shown here, suggest the fcc cubic Co(111) and NiFe (111) preferential growth for all samples.

During the deposition, a 2 kOe constant magnetic field  $H_d$  is applied perpendicularly to the main axis and in the plane of the substrate to induce a magnetic anisotropy and define an easy magnetization axis. The quasi-static magnetic behavior at room temperature is obtained through magnetization curves, acquired along and perpendicular to the main axis of the films, measured using a vibrating sample magnetometer, with maximum external in-plane magnetic field of  $\pm$  300 Oe.

The MI measurements obtained using a RF-impedance analyzer Agilent model *E*4991, with *E*4991*A* test head connected to a microstrip in which the sample is the central conductor. The electric contacts between the sample and the sample holder are made with 24 h cured low resistance silver paint. To avoid propagative effects and acquire just the sample contribution to MI, the analyzer is calibrated at the end of the test head connector by performing open, short, and load (50  $\Omega$ ) measurements using reference standards. Longitudinal MI measurements are performed by acquiring simultaneously the real *R* and imaginary *X* parts of the impedance *Z* over a wide range of frequencies, from 0.1 GHz up



**Fig. 1.** Schematic structure of the ferromagnetic multilayered films, in which n=1, 3 and 5. The arrow indicates the direction of the magnetic field  $H_d$  applied perpendicularly to the main axis and in the plane of the substrate during the deposition.

to 3.0 GHz, with 0 dBm (1 mW) constant power applied to the sample, characterizing the linear regime of driving signal, and magnetic field varying between  $\pm$  300 Oe, applied along the main axis of the sample. Detailed information on the MI experiment is found in Refs. [12,13].

In order to quantify the sensitivity and MI performance as a function of the frequency, we calculate the magnitude of the impedance change at the low field range  $\pm 6$  Oe using the expression [11]

$$\frac{|\Delta Z|}{|\Delta H|} = \frac{|Z(H = 6 \text{ Oe}) - Z(H = -6 \text{ Oe})|}{12}.$$
(1)

Here, we consider the absolute value of  $\Delta Z$ , since the impedance around zero field can present positive or negative slopes, depending on the sample and measurement frequency. In particular, we verify that  $|\Delta Z|/|\Delta H|$  is roughly constant at least for a reasonable low field range.

## 3. Results and discussion

Fig. 2 shows the normalized quasi-static magnetization curves, obtained with the in-plane magnetic field applied both along and perpendicular to the main axis of the films. The angular dependence of the magnetization curves indicates the existence of a magnetic anisotropy for all films, induced by the field applied during the deposition.

By considering the curves acquired with the magnetic field along the main axis, the higher hysteretic losses verified with the raise of n are consistent with the stress stored in the film, roughness of the interfaces and lack of homogeneity of the Cu layer arisen as the total thickness of the sample increases [14,13], as well as related to orange peel and similar effects.

The easy magnetization axis remains perpendicular to the main axis of the substrate, as expected. Along this direction, the films exhibit a biphase magnetic behavior. The two-stage magnetization process is characterized by the magnetization reversion of the soft NiFe layer at low magnetic field, followed by the reversion of the hard Co layer at higher field.

For the films with n=3 and 5, one extra step, during the NiFe reversion, in the magnetization curve is verified. This fact is related to the different magnetic properties between the inner ferromagnetic NiFe layers with respect to deposited first one. In this case, the first NiFe layer deposited on the Ta buffer layer interacts only with one Co layer, while the other NiFe layers are sandwiched between two Co layers. Similar behavior is verified for exchange biased NiFe/IrMn multilayers [15].

In principle, the biphase magnetic behavior could suggests that the ferromagnetic layers are uncoupled. However, in our case, even there is a spacer material between the ferromagnetic layers, we interpret the extra steps as a first indication that the ferromagnetic layers interacts [15].

Regarding the dynamical magnetic behavior, the MI curves reveal important information on the main mechanisms acting at different frequency ranges, such as skin effect and ferromagnetic resonance (FMR) effect at saturated and even unsaturated samples, as well as provide further insights on the energy terms affecting the transverse magnetic permeability and nature of the interactions governing the magnetization dynamics.

Fig. 3 shows the evolution of the MI curves as a function of magnetic field, at selected frequencies, for the multilayered film with n=5. Similar behavior is verified the other studied multilayered films.

The MI measurements present a frequency dependent shift, a feature related to the electrical/metallic contributions of the sample and of the microwave cavity or microstrip employed in the Download English Version:

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